

05N65-TA

Preliminary

Power MOSFET

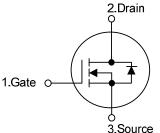
0.5A, 650V N-CHANNEL POWER MOSFET

DESCRIPTION

The UTC 05N65-TA is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- $* R_{DS(ON)} < 15\Omega @ V_{GS} = 10V, I_D = 0.25A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness
- SYMBOL



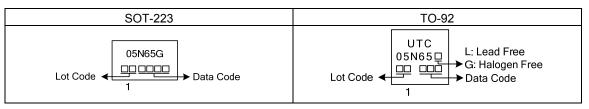
SOT-223 1 TO-92

ORDERING INFORMATION

Ordering Number			Daakaga	Pin Assignment			Packing	
	Lead Free	Halogen Free	Package	1	2	3	Facking	
	-	05N65G-AA3-R	SOT-223	G	D	S	Tape Reel	
	05N65L-T92-B	05N65G-T92-B	TO-92	G	D	S	Таре Вох	
	05N65L-T92-K 05N65G-T92-K		TO-92	G	D	S	Bulk	
Note:	Pin Assianment: G: G	ate D: Drain S: Source	•					

05N65 <u>G</u> - <u>AA3</u> -Ŗ		
	(1)Packing Type	(1) R: Tape Reel, B: Tape Box, K: Bulk
	(2)Package Type	(2) AA3: SOT-223, T92: TO-92
	(3)Green Package	(3) L: Lead Free, G: Halogen Free and Lead Free

MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	650	V
Gate-Source Voltage		V _{GSS}	±30	V
	Continuous	Ι _D	0.5	А
Drain Current	Pulsed (Note 2)	I _{DM}	2.0	А
Avalanche Current (Note 3)		I _{AR}	0.78	А
Avalanche Energy	lanche Energy Single Pulsed (Note 3)		45.6	mJ
Peak Diode Recovery dv/d	ak Diode Recovery dv/dt (Note 4)		4.5	V/ns
	SOT-223	D	6.0	W
Power Dissipation	TO-92	P _D	1.4	W
Junction Temperature		TJ	+150 °(
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L = 150mH, I_{AS} = 0.78A, V_{DD} = 50V, R_G = 25 Ω ,Starting T_J = 25°C

4. $I_{SD} \le 0.5A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C

THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	SOT-223	0	150	°C/W	
Junction to Ambient	TO-92	θ _{JA}	160	°C/W	
lunction to Coop	SOT-223	0	20	°C/W	
Junction to Case	TO-92	θ _{JC}	88	°C/W	



■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

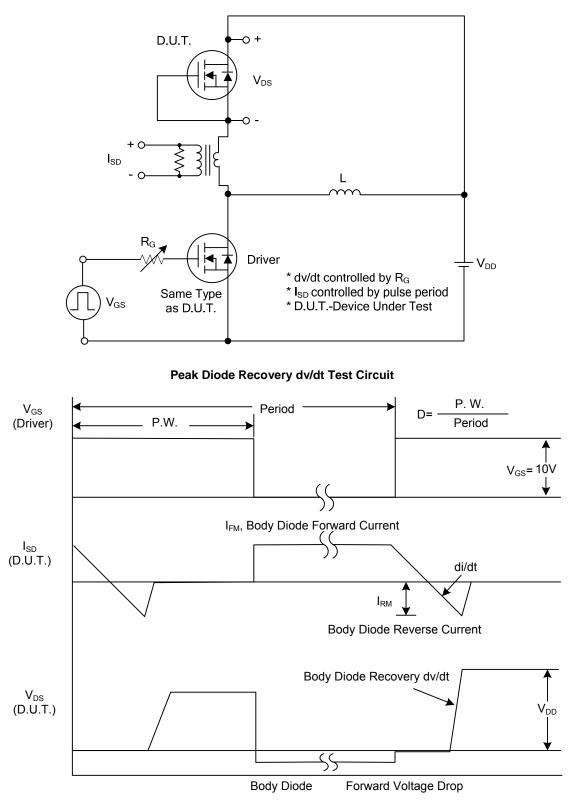
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX		
		STIVIBUL	TEST CONDITIONS	IVIIIN	ITP	IVIAA	UNIT	
				050				
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V	
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			10	μA	
Gate-Source Leakage Current	Forward I _{GSS}		$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
	Reverse	.000	V_{GS} = -30V, V_{DS} = 0V			-100	nA	
ON CHARACTERISTICS				1		1		
Gate Threshold Voltage		V _{GS(TH)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Static Drain-Source On-State Res	sistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 0.25A			15	Ω	
DYNAMIC CHARACTERISTICS					-			
Input Capacitance		CISS			116		рF	
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1MHz		13		рF	
Reverse Transfer Capacitance		C _{RSS}			3.7		рF	
SWITCHING CHARACTERISTIC	S							
Total Gate Charge (Note 1)		Q_{G}	V _{DS} =50V, V _{GS} =10V, I _D =1.3A, I _G = 100µA (Note 1, 2)		6		nC	
Gate to Source Charge		Q_{GS}			1.3		nC	
Gate to Drain Charge		Q_{GD}	$I_{G} = 100 \mu A (100 e 1, 2)$		0.56		nC	
Turn-ON Delay Time (Note 1)		t _{D (ON)}			30		ns	
Rise Time		t _R	V _{DD} =30V, V _{GS} =10V, I _D =0.5A,		10		ns	
Turn-OFF Delay Time		t _{D (OFF)}	R _G =25Ω (Note 1, 2)		48		ns	
Fall-Time		t⊨			20		ns	
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
Maximum Body-Diode Continuou	s Current	ls				0.5	Α	
Maximum Body-Diode Pulsed Current (Note 1)		I _{SM}]			2.0	А	
Drain-Source Diode Forward Voltage (Note 1)		V _{SD}	I _S =0.5A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =0.5A, V _{GS} =0V		170		ns	
Body Diode Reverse Recovery C	harge	Qrr	dI _F /dt = 100A/µs		0.34		μC	

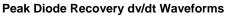
Notes: 1. Pulse Test: Pulse Width≤300µs, Duty Cycle≤2%

2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS





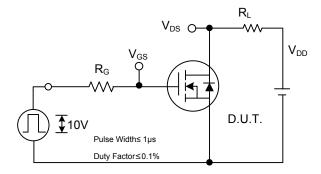


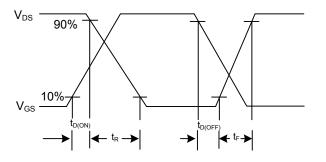
10V

 V_{GS}

Q_{GS}-

■ TEST CIRCUITS AND WAVEFORMS (Cont.)



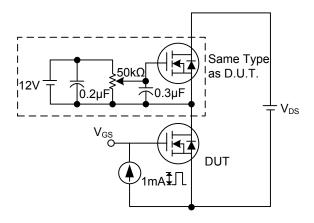


Switching Test Circuit

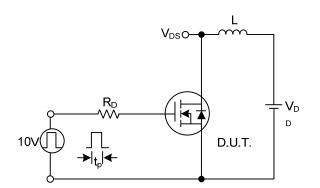


 Q_G

 Q_{GD}



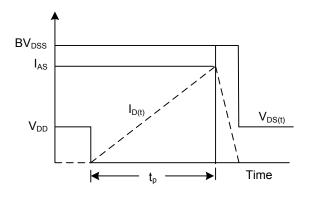
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit

Gate Charge Waveform

Charge



Unclamped Inductive Switching Waveforms



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